TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7MH175FK

#### Quad D-Type Flip-Flop with Clear

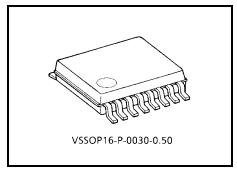
The TC7MH175FK is an advanced high speed CMOS quad D-type flip-flop fabricated with silicon gate  $\rm C^2MOS$  technology.

It achieves the high speed operation similar to equivalent bipolar schottky TTL while maintaining the CMOS low power dissipation.

These four flip-flops are controlled by a clock input (CK) and a clear input ( $\overline{\text{CLR}}$ ).

The information data applied to the D inputs (D1 thru D4) are transferred to the outputs (Q1 thru Q4 and  $\overline{Q}1$  thru  $\overline{Q}4$ ) on the positive-going edge of the clock pulse.

When the  $\overline{\text{CLR}}$  input is held low, the Q outputs are at the low logic level and the  $\overline{\text{Q}}$  outputs are at the high logic level, regardless of other input conditions.



Weight: 0.02 g (typ.)

An input protection circuit ensures that 0 to 5.5 V can be

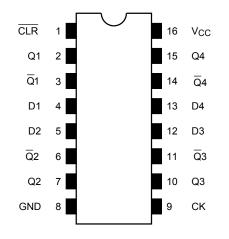
applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

#### Features

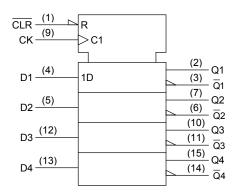
- High speed:  $f_{max} = 210 \text{ MHz} (typ.) (V_{CC} = 5 \text{ V})$
- Low power dissipation:  $I_{CC} = 4 \mu A (max) (Ta = 25^{\circ}C)$
- High noise immunity: V<sub>NIH</sub> = V<sub>NIL</sub> = 28% V<sub>CC</sub> (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays:  $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range:  $V_{CC (opr)} = 2 \sim 5.5 V$
- Low noise: VOLP = 0.8 V (max)
- Pin and function compatible with 74ALS175

## <u>TOSHIBA</u>

## Pin Assignment (top view)



## **IEC Logic Symbol**

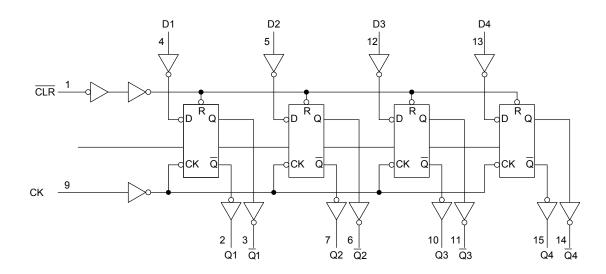


## Truth Table

Inputs			Out	Function	
CLR	D	СК	Q	Q	T unction
L	Х	Х	L	Н	Clear
Н	L		L	Н	_
н	Н		Н	L	_
Н	Х		Qn	$\overline{Q}_{n}$	No change

X: Don't care

## System Diagram



#### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	-0.5~7.0	V
DC input voltage	VIN	-0.5~7.0	V
DC output voltage	Vout	$-0.5 \sim V_{CC} + 0.5$	V
Input diode current	l <sub>IK</sub>	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V <sub>CC</sub> /ground current	Icc	±50	mA
Power dissipation	PD	180	mW
Storage temperature	T <sub>stg</sub>	-65~150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	2.0~5.5	V
Input voltage	VIN	0~5.5	V
Output voltage	V <sub>OUT</sub>	0~V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	-40~85	°C
Input rise and fall time	dt/dv	0~100 (V_{CC}{=}3.3\pm0.3 V)	ns/V
	uluv	0~20 (V_{CC} = 5 $\pm$ 0.5 V)	115/ V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

## **Electrical Characteristics**

#### **DC Characteristics**

Characteristics		Symbol	ymbol Test Condition		_	-	Га = 25°С	)	Ta = -40~85°C		Unit
		Symbol	1031	Test Condition		Min	Тур.	Max	Min	Max	Onit
Input voltage			_		2.0	1.50	—		1.50	—	V
	High level	VIH			3.0~5.5	V <sub>CC</sub> × 0.7	_	_	V <sub>CC</sub> × 0.7	_	
input voltage						_	_	0.50	_	0.50	v
	Low level	VIL	—		3.0~5.5			V <sub>CC</sub> × 0.3	_	V <sub>CC</sub> × 0.3	
	High level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	2.0	1.9	2.0	_	1.9		
					3.0	2.9	3.0		2.9		
					4.5	4.4	4.5	_	4.4		
				$I_{OH} = -4 \text{ mA}$	3.0 2.58 — —	2.48					
Output voltage				$I_{OH} = -8 \text{ mA}$	4.5	3.94	_	_	3.80		V
Output voltage		VOL			2.0		0	0.1		0.1	V
				$I_{OL}=50~\mu A$	3.0	_	0	0.1	—	0.1	
	Low level		$V_{IN} = V_{IH}$ or $V_{IL}$		4.5		0	0.1		0.1	
			- 16	$I_{OL} = 4 \text{ mA}$	3.0			0.36		0.44	
				$I_{OL} = 8 \text{ mA}$	4.5	_	_	0.36		0.44	
Input leakage current		l <sub>IN</sub>	$V_{IN} = 5.5 \text{ V or GND}$		0~5.5	_	—	±0.1	_	±1.0	μA
Quiescent supply	y current	ICC	$V_{IN} = V_{CC}$	$V_{IN} = V_{CC}$ or GND		_	_	4.0		40.0	μA

### Timing Requirements (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Symbol Test Condition		Ta = 25°C		Ta = -40~85°C	Unit	
Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Limit	Limit	Onit	
Minimum pulse width	t <sub>w (L)</sub>		$\textbf{3.3}\pm\textbf{0.3}$	_	5.0	5.0	ns	
(CK)	t <sub>w (H)</sub>		$5.0\pm0.5$	_	5.0	5.0	113	
Minimum pulse width	<b>t</b> (1)		$\textbf{3.3}\pm\textbf{0.3}$	_	5.0	5.0	ns	
( CLR )	t <sub>w (L)</sub>		$5.0\pm0.5$	_	5.0	5.0	115	
Minimum set-up time	ts		$\textbf{3.3}\pm\textbf{0.3}$	—	5.0	5.0	ns	
			$5.0\pm0.5$	_	4.0	4.0	115	
Minimum hold time	th		$\textbf{3.3}\pm\textbf{0.3}$	—	1.0	1.0	ns	
			$5.0\pm0.5$	_	1.0	1.0	115	
Minimum removal time	t		$\textbf{3.3}\pm\textbf{0.3}$	_	5.0	5.0	ns	
( CLR )	t <sub>rem</sub>		$5.0\pm0.5$	_	5.0	5.0	115	

#### AC Characteristics (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol Test Condition				Ta = 25°C			Ta = -40~85°C		Unit
Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	Onit
			3.3 ± 0.3	15		7.5	11.5	1.0	13.5	
Propagation delay time	t <sub>pLH</sub>		5.5 ± 0.5	50	_	10.0	15.0	1.0	17.0	
(CK-Q)	t <sub>pHL</sub>		5.0 ± 0.5	15		4.8	7.3	1.0	8.5	ns
			$5.0 \pm 0.5$	50	_	6.3	9.3	1.0	10.5	
			$3.3\pm0.3$	15		6.3	10.1	1.0	12.0	
Propagation delay time	tрнL	_	3.3 ± 0.3	50		8.8	13.6	1.0	15.5	ns
( <u>CLR</u> -Q)			$5.0\pm0.5$	15		4.3	6.4	1.0	7.5	115
				50	_	5.8	8.4	1.0	9.5	
	f <sub>max</sub> –	_	3.3 ± 0.3	15	90	140		75		MHz
Maximum clock frequency				50	50	75		45		
Maximum clock nequency			$5.0\pm0.5$	15	150	210		125		
				50	85	115	_	75		
Output to output skew	t <sub>osLH</sub>	(Note 1)	$\textbf{3.3}\pm\textbf{0.3}$	50			1.5		1.5	ns
Output to output skew	tosHL	(NOLE T)	$5.0\pm0.5$	50	_	_	1.0		1.0	115
Input capacitance	CIN		_			4	10		10	pF
Power dissipation capacitance	C <sub>PD</sub>			(Note 2)	_	44		_	_	pF

Note 1: Parameter guaranteed by design.

 $t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|$ 

Note 2: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4$  (per bit)

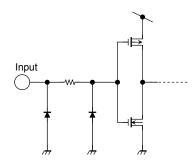
And the total  $\mathsf{C}_{\mathsf{PD}}$  when n pcs of flip-flop operate can be gained by the following equation:

 $C_{PD}$  (total) = 30 + 14  $\cdot$  n

## Noise Characteristics (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition	_	Ta = 25°C		- Unit
Characteristics	Symbol	Test Condition	$V_{CC}(V)$	Тур.	Limit	Offic
Quiet output maximum dynamic $V_{OL}$	VOLP	$C_L = 50 \text{ pF}$	5.0	0.4	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	$C_L = 50 \text{ pF}$	5.0	-0.4	-0.8	V
Minimum high level dynamic input voltage $V_{IH}$	VIHD	$C_L = 50 \text{ pF}$	5.0	_	3.5	V
Maximum low level dynamic input voltage $V_{IL}$	V <sub>ILD</sub>	$C_L = 50 \text{ pF}$	5.0		1.5	V

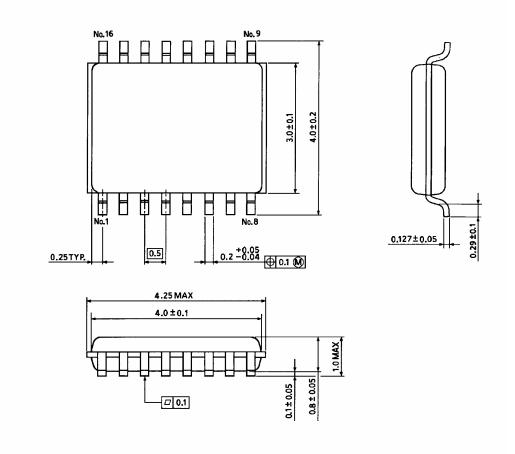
## Input Equivalent Circuit



## **Package Dimensions**

VSSOP16-P-0030-0.50

Unit : mm



Weight: 0.02 g (typ.)

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20070701-EN GENERAL

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